

In re Application of:  
Ling Chen et al.

For: Enhancement of CU Line  
Reliability Using Thin ALD Tan  
Film to Cap the CU Line

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**Examiner:** John M. Parker

## CERTIFICATE OF TRANSMISSION

I hereby certify that this correspondence and the documents referred to as attached therein are being facsimile transmitted to the U.S. Patent and Trademark Office to fax number 571-273-8300, or electronically transmitted to the U.S. Patent and Trademark Office via EFS-Web to the attention of Examiner John M. Parker, on the date shown below.

12/21/06  
Date

Kim M. Parker  
Signature

**SECOND RESPONSE TO FINAL OFFICE ACTION DATED OCTOBER 03, 2006**

**Amendments to the Claims** are reflected in the listing of claims which begins on page 2 of this paper. **Remarks** begin on page 4 of this paper.